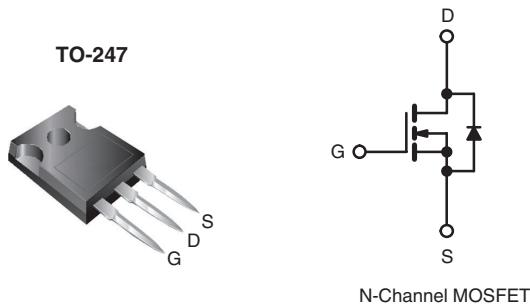


Power MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	60
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.009
Q _g (Max.) (nC)	190
Q _{gs} (nC)	55
Q _{gd} (nC)	90
Configuration	Single



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Ultra Low On- Resistance
- Very Low Thermal Resistance
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- Fast Switching
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP064PbF SiHFP064-E3
SnPb	IRFP064 SiHFP064

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	60	
Gate-Source Voltage		V _{GS}	± 20	V
Continuous Drain Current ^e	V _{GS} at 10 V	I _D	70	A
			70	
Pulsed Drain Current ^a		I _{DM}	520	
Linear Derating Factor			2.0	W/°C
Single Pulse Avalanche Energy ^b		E _{AS}	1000	mJ
Repetitive Avalanche Current ^a		I _{AR}	70	A
Repetitive Avalanche Energy ^a		E _{AR}	30	mJ
Maximum Power Dissipation	T _C = 25 °C	P _D	300	W
Peak Diode Recovery dV/dt ^c		dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature) ^d	for 10 s		300	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- V_{DD} = 25 V, starting T_J = 25 °C, L = 69 μ H, R_G = 25 Ω , I_{AS} = 130 A (see fig. 12).
- I_{SD} ≤ 130 A, dI/dt ≤ 300 A/ μ s, V_{DD} ≤ V_{DS}, T_J ≤ 175 °C.
- 1.6 mm from case.
- Current limited by the package (die current = 130 A).

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

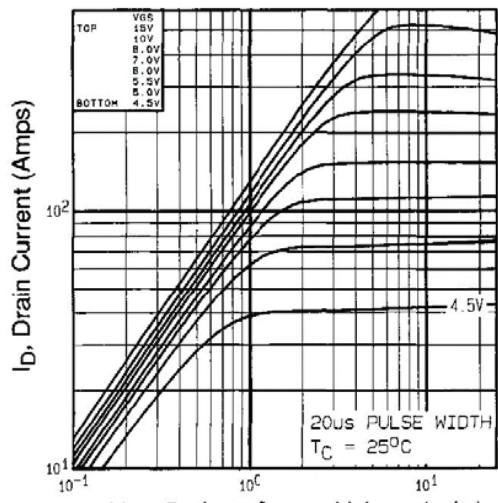
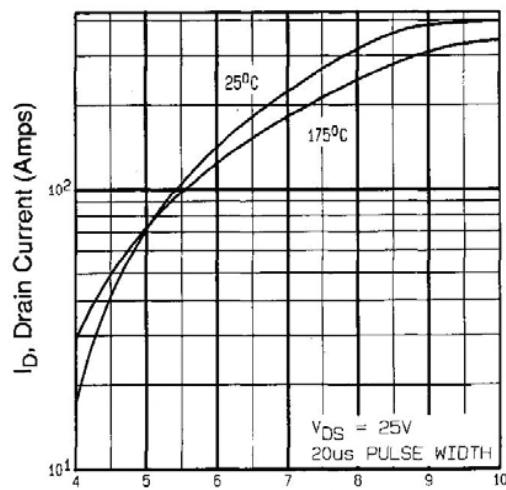
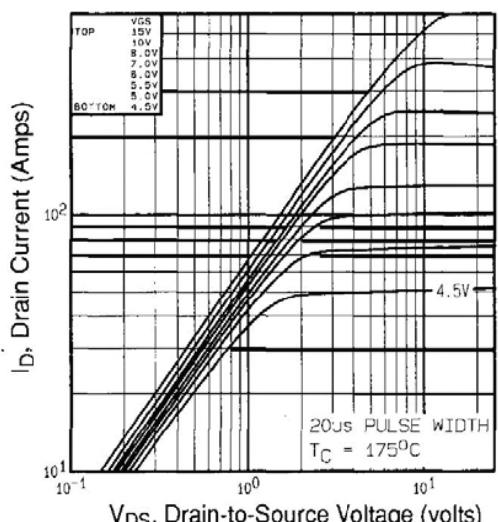
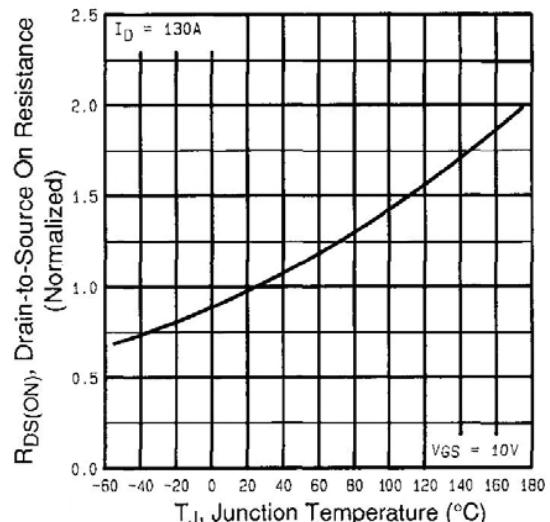
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R_{thJA}	-	40	°C/W
Case-to-Sink, Flat, Greased Surface	R_{thCS}	0.24	-	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.50	

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	60	-	-	V	
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25°C , $I_D = 1 \text{ mA}$		-	0.048	-	$\text{V}/^\circ\text{C}$	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$		2.0	-	4.0	V	
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 60 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	-	25	μA	
		$V_{DS} = 48 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 150^\circ\text{C}$		-	-	250		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 78 \text{ A}^b$	-	-	0.009	Ω	
Forward Transconductance	g_{fs}	$V_{DS} = 25 \text{ V}$, $I_D = 78 \text{ A}^b$		38	-	-	S	
Dynamic								
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1.0 \text{ MHz}$, see fig. 5		-	7400	-	pF	
Output Capacitance	C_{oss}			-	3200	-		
Reverse Transfer Capacitance	C_{rss}			-	540	-		
Total Gate Charge	Q_g	$V_{GS} = 10 \text{ V}$	$I_D = 130 \text{ A}$, $V_{DS} = 48 \text{ V}$, see fig. 6 and 13 ^b	-	-	190	nC	
Gate-Source Charge	Q_{gs}			-	-	55		
Gate-Drain Charge	Q_{gd}			-	-	90		
Turn-On Delay Time	$t_{d(on)}$			-	21	-		
Rise Time	t_r	$V_{DD} = 30 \text{ V}$, $I_D = 130 \text{ A}$, $R_G = 4.3 \Omega$, $R_D = 0.22 \Omega$, see fig. 10 ^b		-	190	-	ns	
Turn-Off Delay Time	$t_{d(off)}$			-	110	-		
Fall Time	t_f			-	190	-		
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH	
Internal Source Inductance	L_S			-	13	-		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	70 ^c	A	
Pulsed Diode Forward Current ^a	I_{SM}			-	-	520		
Body Diode Voltage	V_{SD}	$T_J = 25^\circ\text{C}$, $I_S = 130 \text{ A}$, $V_{GS} = 0 \text{ V}^b$		-	-	3.0	V	
Body Diode Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_F = 130 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	160	250	ns	
Body Diode Reverse Recovery Charge	Q_{rr}			-	0.9	1.7	μC	
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2\%$.
c. Current limited by the package (die current = 130 A).

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics, $T_C = 25^\circ\text{C}$

Fig. 3 - Typical Transfer Characteristics

Fig. 2 - Typical Output Characteristics, $T_C = 175^\circ\text{C}$

Fig. 4 - Normalized On-Resistance vs. Temperature

IRFP064, SiHFP064



Vishay Siliconix

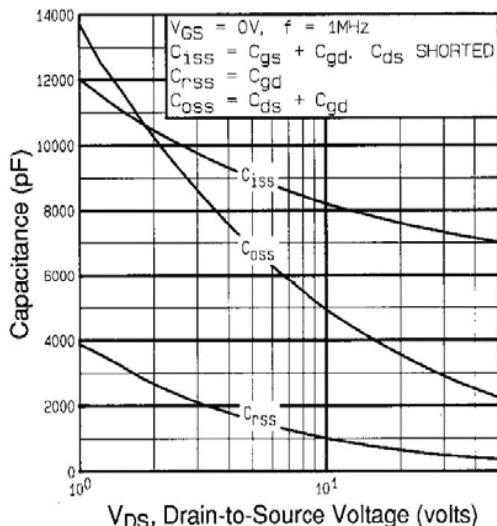


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

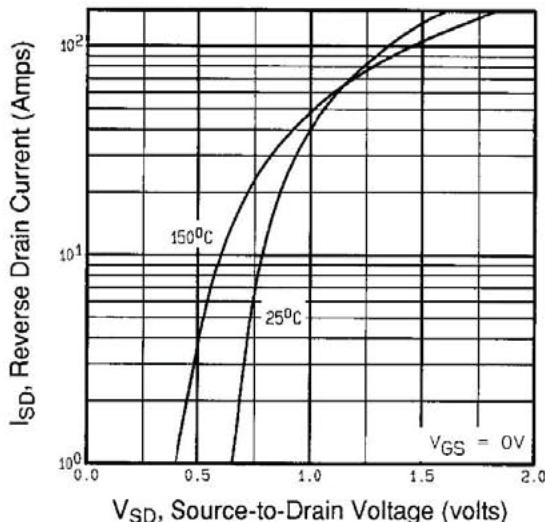


Fig. 7 - Typical Source-Drain Diode Forward Voltage

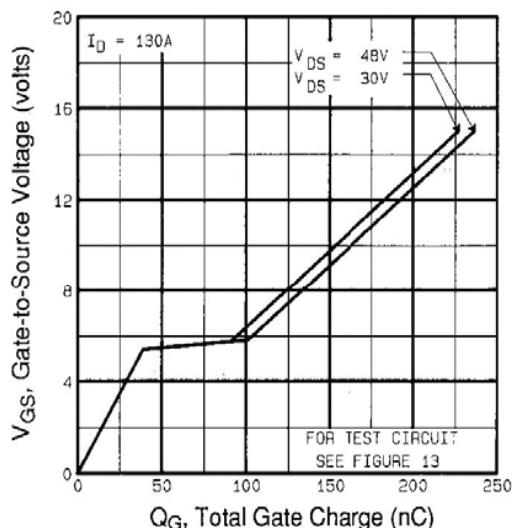


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

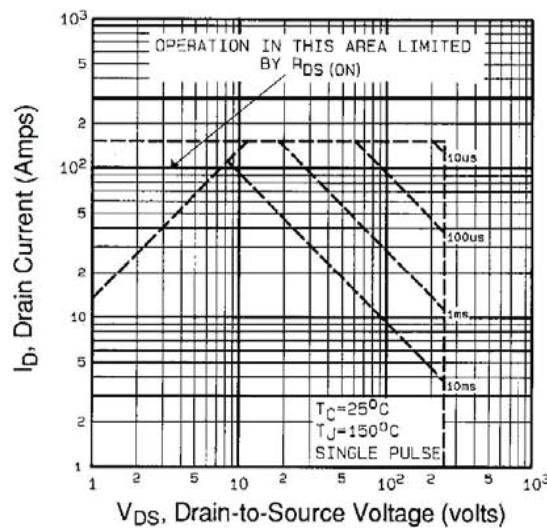


Fig. 8 - Maximum Safe Operating Area

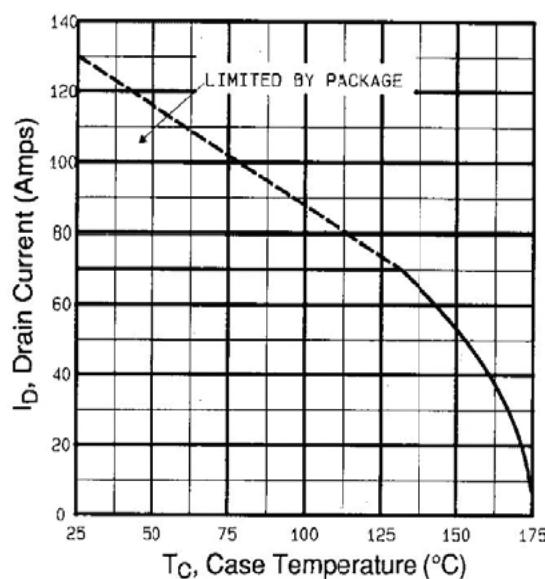


Fig. 9 - Maximum Drain Current vs. Case Temperature

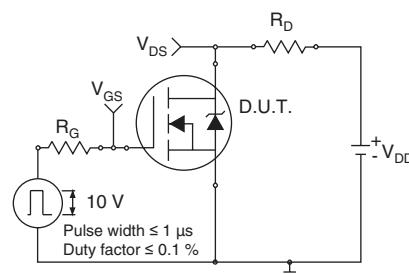


Fig. 10a - Switching Time Test Circuit

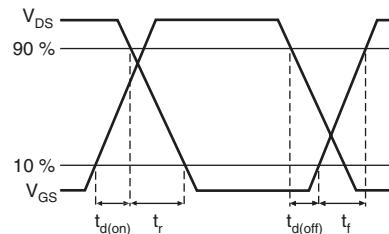


Fig. 10b - Switching Time Waveforms

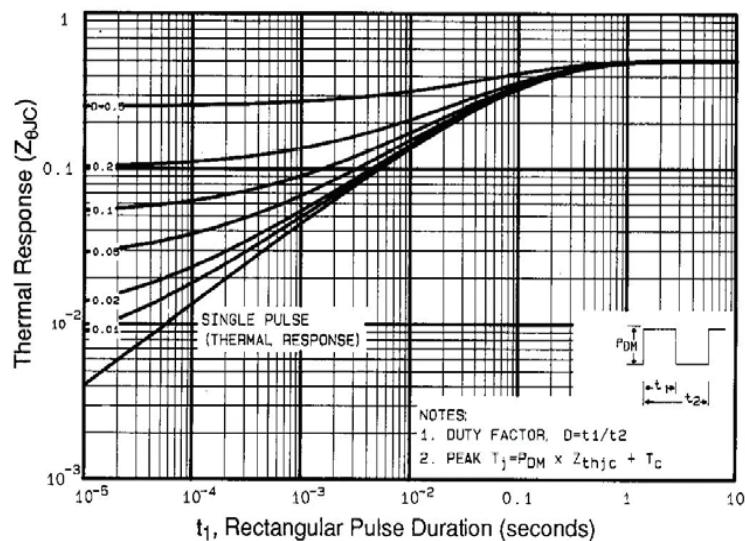


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

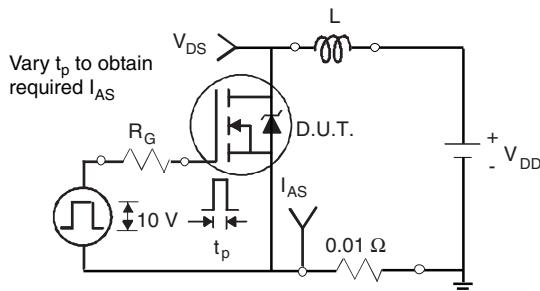


Fig. 12a - Unclamped Inductive Test Circuit

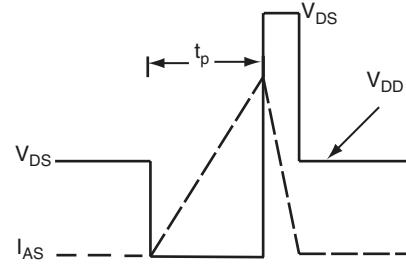


Fig. 12b - Unclamped Inductive Waveforms

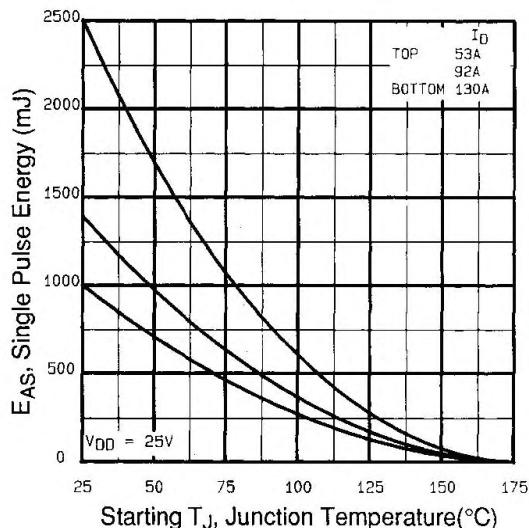


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

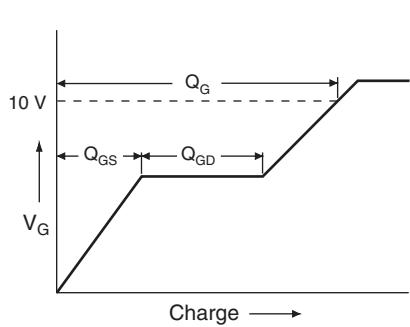


Fig. 13a - Basic Gate Charge Waveform

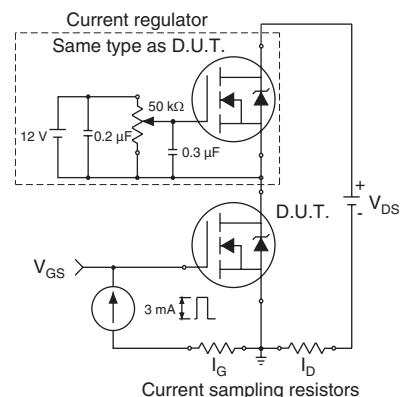
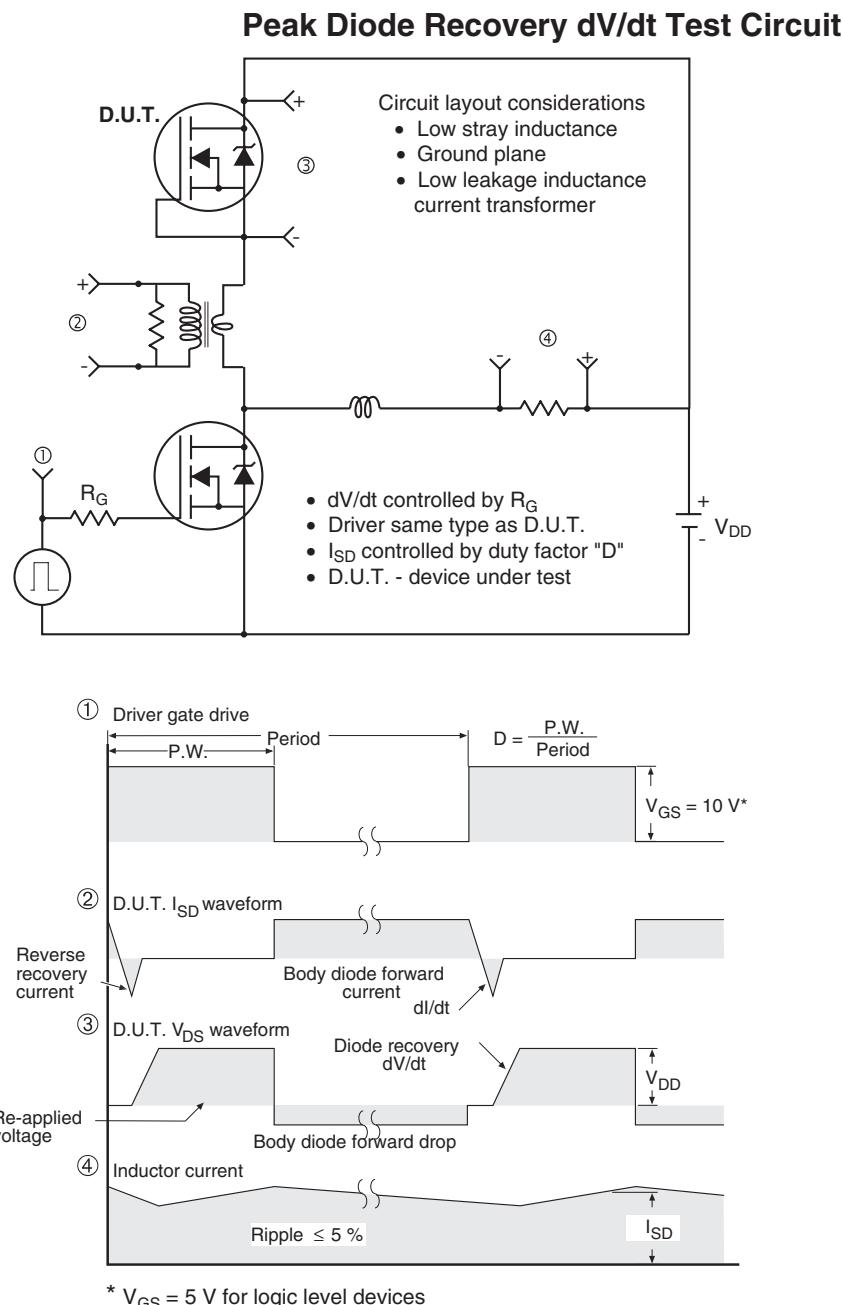


Fig. 13b - Gate Charge Test Circuit


Fig. 14 - For N-Channel

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